







NOTES/SPECIFICATIONS:

- 1.
- 2. 3.
- CLEAR APERTURE: > ϕ 21.6 mm SURFACE QUALITY (S1): 10-5 SCRATCH-DIG SURFACE FLATNESS (S1): λ /10 AT 633 nm (S2): FINE GRIND
- 4. 5. 6. 7.

- (S2): FINE GRIND PARALLELISM: \leq 3 arcmin THICKNESS TOLERANCE: \pm 0.2 mm DIAMETER TOLERANCE: \pm 0.0/-0.1 mm DESIGN WAVELENGTH RANGE: 400-750 nm COATING: BROADBAND HR, DIELECTRIC Rs avg: >99% FROM 400-750 nm Rp avg: >99% FROM 400-750 nm AOI: 0° TO 45° DAMAGE THRESHOLD: 0.250 J/cm² 10 ns PUIL 8.
- DAMAGE THRESHOLD: 0.250 J/cm² 10 ns PULSE, 10 Hz AT 532 nm 9.

FOR INFORMATION ONLY NOT FOR MANUFACTURING PURPOSES

DRAWING PROJECTION					
	NAME	DATE	Ø 25.4 mm BROADBAND MIRROR		2
DRAWN	BAG	25/OCT/10	400-750 nm		`
APPROVAL	BW	04/NOV/21	FUSED SILICA		REV
COPYRIGHT © 2021 BY THORLABS			FUSED SILICA		F
VALUES IN PARENTHESIS ARE CALCULATED AND MAY CONTAIN ROUNDOFF ERRORS			BB1-E02	APPROX WEIGHT	